## Search Notes



Application/Control No.
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Applicant(s)/Patent Under Reexamination KITSUTAKA, SHIGERU

Part of Paper No.: 20090327

Art Unit

Examiner

3714

## SEARCHED

Class	Subclass	Date	Examiner		
345	426, 429-431, 592, 418-422	3/27/2009	FML		
463	30-33	3/27/2009	FML		

## SEARCH NOTES

Search Notes	Date	Examiner
((SHIGERU) near2 (KITSUTAKA)).INV.	3/27/2009	FML
((second near depth near value) and (focus near position) and (virtual near camera)).clm.	3/27/2009	FML
See attached East search report	3/27/2009	FML
Search consultation with Xiao Wu AU2628	3/27/2009	FML
Search consultation with Jason Repko AU2628	3/27/2009	FML

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
345	426, 429-431, 592, 418-422	3/27/2009	FML
463	30-33	3/27/2009	FML

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